

Sheet 1 of 1

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-2269	SERIAL NO. 10/622,118
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT: Gurtej S. Sandhu et al.	
				FILING DATE April 8, 2004	GROUP ART UNIT 2818

U.S. PATENT DOCUMENTS							
Examiner's Initials	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
DV	AA	5,994,194	11/99	Lamman			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						

FOREIGN PATENT DOCUMENTS							
Document Number	Date	Country	Class	Subclass	Translation		
					Yes	No	

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)		
	AM	
	AM	
	AD	


  

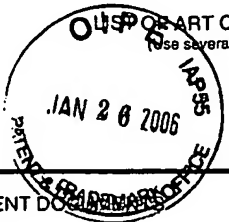
EXAMINER <i>Shulard</i>	DATE CONSIDERED 10/01/06
----------------------------	-----------------------------

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. M22-2268		SERIAL NO. 10/822,118		
LIST OF ART CITED BY APPLICANT <small>(Use several sheets if necessary)</small>				APPLICANT: Gurtej 3. Sandhu et al.				
				FILING DATE April 8, 2004		GROUP ART UNIT 2818		
<b>U.S. PATENT DOCUMENTS</b>								
Examiner's Initials	Class	Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate	
DV	AA	6,582,888	06/03	Herbst et al.				
DV	AB	6,613,240	09/03	Skinner et al.				
	AC							
	AD							
	AE							
	AF							
	AG							
	AH							
	AI							
<b>FOREIGN PATENT DOCUMENTS</b>								
		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
DV	AJ	JP 2002-323775	11/02	JAPAN			X	
	AK							
	AL							
<b>OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)</b>								
	AM							
	AN							
	AO							
EXAMINER <i>Strulovici</i>		DATE CONSIDERED 10/01/06						
<small>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 608; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>								

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-2268		SERIAL NO. 10/822,118	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT: Gurtej S. Sandhu et al.			
				FILING DATE April 8, 2004		GROUP ART UNIT 2818	
<b>U.S. PATENT DOCUMENTS</b>							
Examiner's Initials	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
DV	AA	6,582,861 B2	06/2003	Buxbaum et al.	—	—	—
DV	AB	6,956,980 B2	10/2005	Nagata et al.	—	—	—
DV	AC	2005/0244571 A1	11/2005	Walheim et al.	—	—	—
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
<b>FOREIGN PATENT DOCUMENTS</b>							
Document Number	Date	Country	Class	Subclass	Translation		
					Yes	No	
AJ							
AK							
AL							
<b>OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)</b>							
AM							
AN							
AO							
EXAMINER <i>Shuler</i>		DATE CONSIDERED 10/01/06					
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-2268	SERIAL NO. 10/822,118			
 <p>LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)</p>				APPLICANT: Gurtej S. Sandhu et al.				
				FILING DATE April 8, 2004	GROUP <del>2812</del> 2818			
<b>U.S. PATENT DOCUMENTS</b>								
Examiner's Initials	AA	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
DV	AA	3,772,101	11/73	Chumbres et al.				
DV	AB	5,677,102	10/97	Shiihara				
DV	AC	6,096,634	08/00	Nguyen				
DV	AD	6,238,994	05/01	Derderian et al.				
DV	AE	6,255,035	07/01	Minter et al.				
DV	AF	6,297,527	10/01	Agarwal et al.				
DV	AG	6,376,149	04/02	Grober et al.				
DV	AH	6,399,982	06/02	Derderian et al.				
DV	AI	6,511,896	01/03	Basceri et al.				
DV	AJ	6,608,343	08/03	Derderian et al.				
DV	AK	6,617,250	09/03	Basceri et al.				
DV	AL	6,649,466	11/03	Basceri et al.				
DV	AM	6,744,093	06/04	Agarwal et al.				
<b>FOREIGN PATENT DOCUMENTS</b>								
		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
	AN							
<b>OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)</b>								
	AO							
EXAMINER <i>Shuland</i>		DATE CONSIDERED 10/01/06						
<small>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>								

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-2268		SERIAL NO. 10/822,118	
				APPLICANT: Gurtej S. Sandhu et al.			
				FILING DATE April 8, 2004		GROUP -2812 2818	
U.S. PATENT DOCUMENTS							
*Examiner's Initials	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
DV	AA	6,746,916	06/04	Agarwal et al.			
DV	AB	6,777,739	08/04	Agarwal et al.			
DV	AC	6,780,766	08/04	Basceri et al.			
DV	AD	6,817,086	11/04	Lu et al.			
DV	AE	6,900,497	05/05	Agarwal et al.			
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
FOREIGN PATENT DOCUMENTS							
	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
	AN						
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
	AO						
EXAMINER <i>Bruland</i>		DATE CONSIDERED 10/01/06					
<small>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							